

Notice of References Cited	Application/Control No. 10/759,719		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner SHIN-HON CHEN		Art Unit 2131	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0164035	11-2002	Yokota et al.	380/278
*	C	US-7,184,553	02-2007	Mahlab et al.	380/256
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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